

Notice of References Cited	Application/Control No. 09/892,732	Applicant(s)/Patent Under Reexamination IWAYAMA ET AL.	
	Examiner Khanh H. Le	Art Unit 3622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0184886	08-2006	Chung et al.	715/758
*	B	US-6,708,172	03-2004	Wong et al.	707/10
	C	US-			
	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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